Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	18862	imag$3 and (slot$1 or slit$ or line$1) and (detect$ near3 (motion$ or movement$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/07/30 14:13
S2	4510	imag$3 and ((slot$1 or slit$ or line$1) same (detect$ near3 (motion$ or movement$1)))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/07/30 14:13
S3	331	imag$3 and (slit$ same (detect$ near3 (motion$ or movement$1)))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/07/30 14:19
S4	405	shukla.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/07/30 15:04
S5	3	"11134506".pn.",08221577".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:15
S6	783771	hitachi.as.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:16
S7	76768	hitachi.as. and mov$5	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:16
S8	1653	(hitachi.as. and mov$5) and slit	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:18
S9	20176	Hirokazu.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:19
S10	1086	hitachi.as. and Hirokazu.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:19

S11	38389	yasuyuki.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:19
S12	11	(hitachi.as. and Hirokazu.in.) and yasuyuki.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:19
S13	2	"6584211".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:44
S14	1317	382/103,104,107.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:45
S15	502	382/103,104,107.ccls. and (segment$6 or slit$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:45
S16	26	382/103,104,107.ccls. and slit$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 13:46
S17	5	(double near6 slit$1) same (detect$6 near5 (mov$6 or motion$))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 14:05
S18	1874	double near6 slit$1	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 14:06
S19	58	(double near6 slit$1) and (object near4 (motion or mov$6))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 14:07
S20	40	((double near6 slit$1) and (object near4 (motion or mov$6))) and image$1	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 14:07

S21	40	((double near6 slit$1) and (object near4 (motion or mov$6))) and image$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 14:07
S22	40	((double near6 slit$1) and (object near4 (motion or mov$6))) and imag$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/03 14:07
S23	7	(US-6005493-$ or US-6766038-$ or US-5771485-$ or US-5329595-$).did. or (JP-08221577-$).did. or (EP-913799-$ or JP-08221577-$).did.	USPAT; JPO; DERWENT	OR	OFF	2004/09/06 14:42
S24	1	((US-6005493-$ or US-6766038-$ or US-5771485-$ or US-5329595-$).did. or (JP-08221577-$).did. or (EP-913799-$ or JP-08221577-$).did.) and (object near4 (length or height))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 14:45
S25	0	((US-6005493-$ or US-6766038-$ or US-5771485-$ or US-5329595-$).did. or (JP-08221577-$).did. or (EP-913799-$ or JP-08221577-$).did.) and (object near4 (height))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 14:45
S26	684	slit$1 and (object near4 (height))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 14:45
S27	30	slit$s and (determin$6 near4 (object near4 height))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 14:47
S28	30	slit$s and (determin$6 near4 ((mov$5near3 object) near4 height))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 14:47
S29	1	slit$s and (determin$6 near4 ((mov$5 near3 object) near4 height))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 14:52
S30	2	"6584211".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 14:52

S31	1	"6584211".pn. and (length or height)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:31
S32	1	"5721692".pn. and (length or height)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 14:54
S33	784227	Hitachi.as.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:31
S34	196	Hitachi.as. and (object near3 height)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:32
S35	1048	johns.xp.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:32
S36	1	(Hitachi.as. and (object near3 height)) and johns.xp.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:33
S37	14268	(different near6 (length$1 or size$1 or dimension$1)) same (slit$1 or segment$1 or sector$1)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:39
S38	277	((different near6 (length$1 or size$1 or dimension$1)) same (slit$1 or segment$1 or sector$1)) and (mov$3 near3 object)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:37
S39	7	(US-5329595-$ or US-5771485-$ or US-6766038-$ or US-6005493-$). did. or (JP-08221577-$).did. or (JP-08221577-$ or EP-913799-$). did.	USPAT; JPO; DERWENT	OR	OFF	2004/09/06 15:46

S40	0	((different near6 (length$1 or size$1 or dimension$1)) same (slit$1 or segment$1 or sector$1)) and ((US-5329595-$ or US-5771485-$ or US-6766038-$ or US-6005493-$).did. or (JP-08221577-$).did. or (JP-08221577-$ or EP-913799-$).did.)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:37
S41	0	((US-5329595-$ or US-5771485-$ or US-6766038-$ or US-6005493-$).did. or (JP-08221577-$).did. or (JP-08221577-$ or EP-913799-$).did.) and (different near6 (length$1 or size$1 or dimension$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:39
S42	0	((US-5329595-$ or US-5771485-$ or US-6766038-$ or US-6005493-$).did. or (JP-08221577-$).did. or (JP-08221577-$ or EP-913799-$).did.) and ((different or multiple or two) near6 (length$1 or size$1 or dimension$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:39
S43	11	((different near6 (length$1 or size$1 or dimension$1)) same (slit$1 or segment$1 or sector$1) same (mov$3 near3 object$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:57
S44	0	((US-5329595-$ or US-5771485-$ or US-6766038-$ or US-6005493-$).did. or (JP-08221577-$).did. or (JP-08221577-$ or EP-913799-$).did.) and cod$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:47
S45	0	((US-5329595-$ or US-5771485-$ or US-6766038-$ or US-6005493-$).did. or (JP-08221577-$).did. or (JP-08221577-$ or EP-913799-$).did.) and cod$7	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:47
S46	2113	(moving near4 object$6) same cod$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:47
S47	21	((moving near4 object$6) same cod$3) and slits	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:47
S48	9	((different near4 (length$1 or size$1)) same (slit$1 or segment$1 or sector$1) same (mov$3 near3 object$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:58

S49	12102	(different near4 (length$1 or size$1)) same (slit$1 or segment$1 or sector$1)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:58
S50	231	((different near4 (length$1 or size$1)) same (slit$1 or segment$1 or sector$1) and (mov$3 near3 object$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 15:59
S51	2	"5721692".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 19:12
S52	0	"5721692".pn. and cod$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 19:12
S53	0	"5721692".pn. and (cod$3 or label$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 19:12
S54	4	"5721692".pn.",4160522".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 19:26
S55	2	"4459487".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/09/06 19:34
S56	5741	382/100,103,104, 107;73/488;348/154,155;356/27, 28,28.5.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 14:11
S57	5796	382/100,103,104, 107;73/488;348/154,155;356/11, 27,28,28.5.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 14:11
S58	742	S57 and (((imag$4 frame$1) same (slit$5 area$4 region$4 block$4 rectangl$6)) same (height$ length$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 14:17

S59	536	S58 and ((two three multipl$4 plural$4 several myriad different unequal) near4 (slit$5 area$4 region$4 block$4 rectangl$6))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 14:37
S60	115	S59 and ((object$1 subject$1 person$1 individual$4 automobil$ vehic$6 car$1 truck$1 bus$3) near3 (height$ length$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 14:39
S61	79	S60 and ((detect$4 comput$4 determin$5 calculat$4 obtain$4 generat$4) near5 (height$1 length$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 14:41
S62	4735	((two double$4 three triple$1 multipl$4 plural$4 several myriad different unequal) near4 (slit$5 area$4 region$4 block$4 rectangl$6 segment$1 line$1 strip$4)) same ((object$1 subject$1 person$1 individual$4 automobil$ vehic$6 car$1 truck$1 bus$3) near3 (height$ length$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 14:40
S63	1591	S62 and ((detect$4 comput$4 determin$5 calculat$4 obtain$4 generat$4) near5 (height$1 length$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 14:41
S64	1092	S63 and (imag$3 video$ frame$1)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/30 15:23

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IEE JNL IEE Journal or Magazine

IEEE CNF IEEE Conference Proceeding

IEE CNF IEE Conference Proceeding

IEEE STD IEEE Standard

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Beekman, F.J.; Kamphuis, C.; Viergever, M.A.;
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☐   6. **Keeping track of the big event**
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8. **Lane detection by orientation and length discrimination**
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